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[International Rectifier \(Infineon Technologies Americas Corp.\)  
IRFSL4229PBF](#)

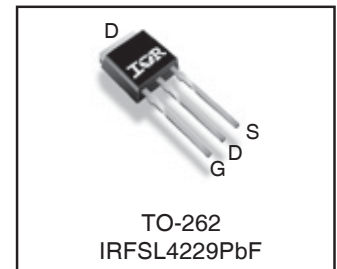
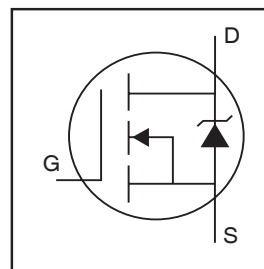
For any questions, you can email us directly:

[sales@integrated-circuit.com](mailto:sales@integrated-circuit.com)

### Features

- Advanced Process Technology
- Low  $Q_G$  for Fast Response
- High Repetitive Peak Current Capability for Reliable Operation
- Short Fall & Rise Times for Fast Switching
- 175°C Operating Junction Temperature for Improved Ruggedness
- Repetitive Avalanche Capability for Robustness and Reliability

| Key Parameters                           |     |    |
|--|-----|----|
| $V_{DS}$ min                             | 250 | V  |
| $V_{DS}$ (Avalanche) typ.                | 300 | V  |
| $R_{DS(ON)}$ typ. @ 10V                  | 42  | mΩ |
| $I_{RP}$ max @ $T_C = 100^\circ\text{C}$ | 91  | A  |
| $T_J$ max                                | 175 | °C |



| G    | D     | S      |
|------|-------|--------|
| Gate | Drain | Source |

### Description

This HEXFET® Power MOSFET utilizes the latest processing techniques to achieve low on-resistance per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device.

### Absolute Maximum Ratings

|                                      | Parameter                                | Max.             | Units |
|--------------------------------------|--|------------------|-------|
| $V_{GS}$                             | Gate-to-Source Voltage                   | ±30              | V     |
| $I_D$ @ $T_C = 25^\circ\text{C}$     | Continuous Drain Current, $V_{GS}$ @ 10V | 45               | A     |
| $I_D$ @ $T_C = 100^\circ\text{C}$    | Continuous Drain Current, $V_{GS}$ @ 10V | 32               |       |
| $I_{DM}$                             | Pulsed Drain Current ①                   | 180              |       |
| $I_{RP}$ @ $T_C = 100^\circ\text{C}$ | Repetitive Peak Current ⑤                | 91               |       |
| $P_D$ @ $T_C = 25^\circ\text{C}$     | Power Dissipation                        | 330              | W     |
| $P_D$ @ $T_C = 100^\circ\text{C}$    | Power Dissipation                        | 190              |       |
|                                      | Linear Derating Factor                   | 2.2              | W/°C  |
| $T_J$                                | Operating Junction and                   | -40 to + 175     | °C    |
| $T_{STG}$                            | Storage Temperature Range                |                  |       |
|                                      | Soldering Temperature for 10 seconds     | 300              |       |
|                                      | Mounting Torque, 6-32 or M3 Screw        | 10lb·in (1.1N·m) | N     |

### Thermal Resistance

|                 | Parameter             | Typ. | Max.  | Units |
|-----------------|-----------------------|------|-------|-------|
| $R_{\theta JC}$ | Junction-to-Case ④    | —    | 0.45* |       |
| $R_{\theta JA}$ | Junction-to-Ambient ④ | —    | 62    |       |

\*  $R_{\theta JC}$  (end of life) for TO-262 = 0.65°C/W. This is the maximum measured value after 1000 temperature cycles from -55 to 150°C and is accounted for by the physical wearout of the die attach medium.

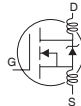
Notes ① through ⑤ are on page 8

# IRFSL4229PbF

International  
**IR** Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                | Parameter                            | Min. | Typ. | Max. | Units | Conditions  |
|--------------------------------|--------------------------------------|------|------|------|-------|---|
| $BV_{DSS}$                     | Drain-to-Source Breakdown Voltage    | 250  | —    | —    | V     | $V_{GS} = 0V, I_D = 250\mu A$   |
| $\Delta BV_{DSS}/\Delta T_J$   | Breakdown Voltage Temp. Coefficient  | —    | 210  | —    | mV/°C | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$   |
| $R_{DS(on)}$                   | Static Drain-to-Source On-Resistance | —    | 42   | 48   | mΩ    | $V_{GS} = 10V, I_D = 26A$ ③   |
| $V_{GS(th)}$                   | Gate Threshold Voltage               | 3.0  | —    | 5.0  | V     | $V_{DS} = V_{GS}, I_D = 250\mu A$   |
| $\Delta V_{GS(th)}/\Delta T_J$ | Gate Threshold Voltage Coefficient   | —    | -14  | —    | mV/°C |   |
| $I_{DSS}$                      | Drain-to-Source Leakage Current      | —    | —    | 20   | μA    | $V_{DS} = 250V, V_{GS} = 0V$  |
|                                |                                      | —    | —    | 200  |       | $V_{DS} = 250V, V_{GS} = 0V, T_J = 125^\circ\text{C}$   |
| $I_{GSS}$                      | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA    | $V_{GS} = 20V$  |
|                                | Gate-to-Source Reverse Leakage       | —    | —    | -100 |       | $V_{GS} = -20V$   |
| $g_{fs}$                       | Forward Transconductance             | 83   | —    | —    | S     | $V_{DS} = 25V, I_D = 26A$   |
| $Q_g$                          | Total Gate Charge                    | —    | 72   | 110  | nC    | $V_{DD} = 125V, I_D = 26A, V_{GS} = 10V$ ③  |
| $Q_{gd}$                       | Gate-to-Drain Charge                 | —    | 26   | —    |       |   |
| $t_{d(on)}$                    | Turn-On Delay Time                   | —    | 18   | —    | ns    | $V_{DD} = 125V, V_{GS} = 10V$ ③<br>$I_D = 26A$<br>$R_G = 2.4\Omega$<br>See Fig. 22                          |
| $t_r$                          | Rise Time                            | —    | 31   | —    |       |   |
| $t_{d(off)}$                   | Turn-Off Delay Time                  | —    | 30   | —    |       |   |
| $t_f$                          | Fall Time                            | —    | 21   | —    |       |   |
| $t_{st}$                       | Shoot Through Blocking Time          | 100  | —    | —    | ns    | $V_{DD} = 200V, V_{GS} = 15V, R_G = 4.7\Omega$  |
| $E_{PULSE}$                    | Energy per Pulse                     | —    | 790  | —    | μJ    | $L = 220\text{nH}, C = 0.3\mu F, V_{GS} = 15V$<br>$V_{DS} = 200V, R_G = 4.7\Omega, T_J = 25^\circ\text{C}$  |
|                                |                                      | —    | 1390 | —    |       | $L = 220\text{nH}, C = 0.3\mu F, V_{GS} = 15V$<br>$V_{DS} = 200V, R_G = 4.7\Omega, T_J = 100^\circ\text{C}$ |
| $C_{iss}$                      | Input Capacitance                    | —    | 4560 | —    | pF    | $V_{GS} = 0V$<br>$V_{DS} = 25V$<br>$f = 1.0\text{MHz},$<br>$V_{GS} = 0V, V_{DS} = 0V$ to 200V               |
| $C_{oss}$                      | Output Capacitance                   | —    | 390  | —    |       |   |
| $C_{rss}$                      | Reverse Transfer Capacitance         | —    | 100  | —    |       |   |
| $C_{oss\ eff.}$                | Effective Output Capacitance         | —    | 290  | —    |       |   |
| $L_D$                          | Internal Drain Inductance            | —    | 4.5  | —    | nH    | Between lead,<br>and center of die contact  |
| $L_S$                          | Internal Source Inductance           | —    | 7.5  | —    |       |   |

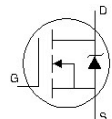


## Avalanche Characteristics

|                     | Parameter                       | Typ. | Max. | Units |
|---------------------|---------------------------------|------|------|-------|
| $E_{AS}$            | Single Pulse Avalanche Energy ② | —    | 130  | mJ    |
| $E_{AR}$            | Repetitive Avalanche Energy ①   | —    | 33   | mJ    |
| $V_{DS(Avalanche)}$ | Repetitive Avalanche Voltage ①  | 300  | —    | V     |
| $I_{AS}$            | Avalanche Current ②             | —    | 26   | A     |

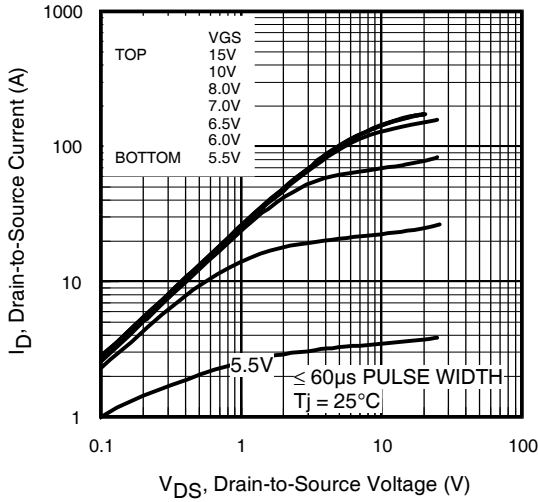
## Diode Characteristics

|                                | Parameter                                 | Min. | Typ. | Max. | Units | Conditions  |
|--------------------------------|---|------|------|------|-------|---|
| $I_S @ T_C = 25^\circ\text{C}$ | Continuous Source Current<br>(Body Diode) | —    | —    | 45   | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| $I_{SM}$                       | Pulsed Source Current<br>(Body Diode) ①   | —    | —    | 180  |       |   |
| $V_{SD}$                       | Diode Forward Voltage                     | —    | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 26A, V_{GS} = 0V$ ③                      |
| $t_{rr}$                       | Reverse Recovery Time                     | —    | 190  | 290  | ns    | $T_J = 25^\circ\text{C}, I_F = 26A, V_{DD} = 50V$                       |
| $Q_{rr}$                       | Reverse Recovery Charge                   | —    | 840  | 1260 | nC    | $di/dt = 100A/\mu s$ ③  |

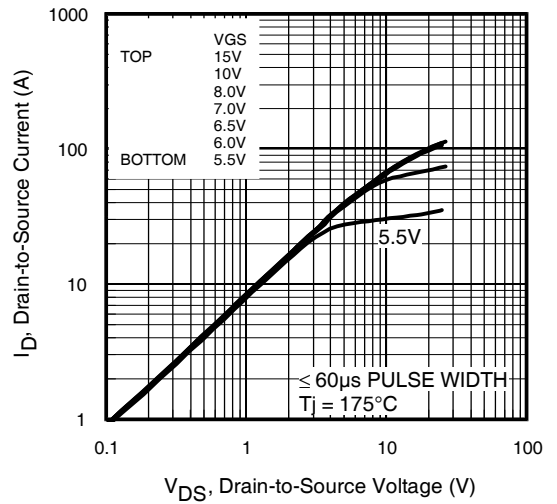


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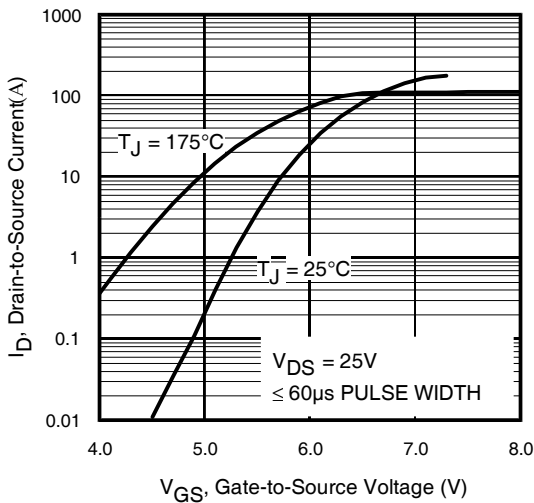
# IRFSL4229PbF



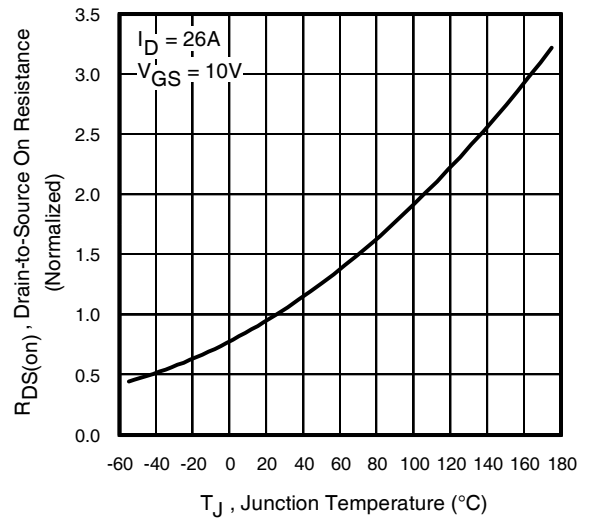
**Fig 1.** Typical Output Characteristics



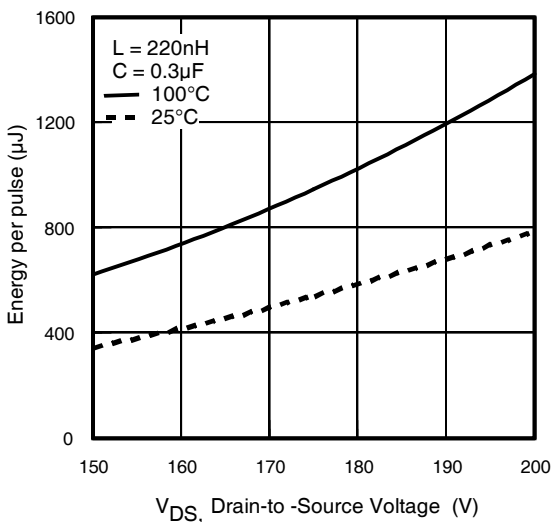
**Fig 2.** Typical Output Characteristics



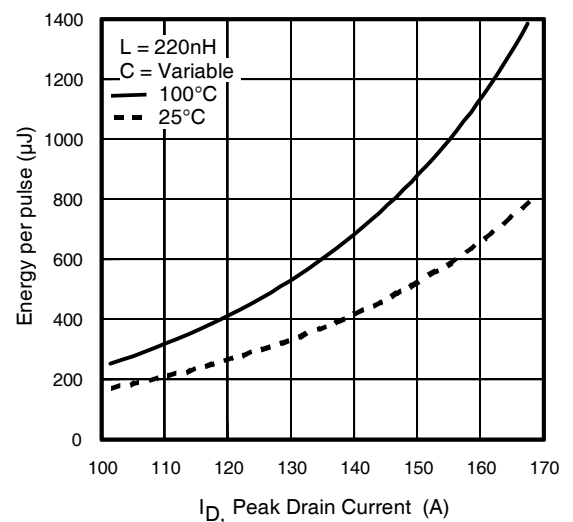
**Fig 3.** Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance vs. Temperature

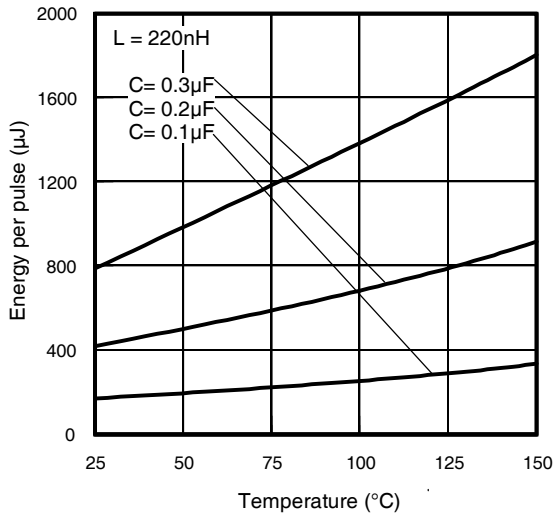


**Fig 5.** Typical  $E_{PULSE}$  vs. Drain-to-Source Voltage

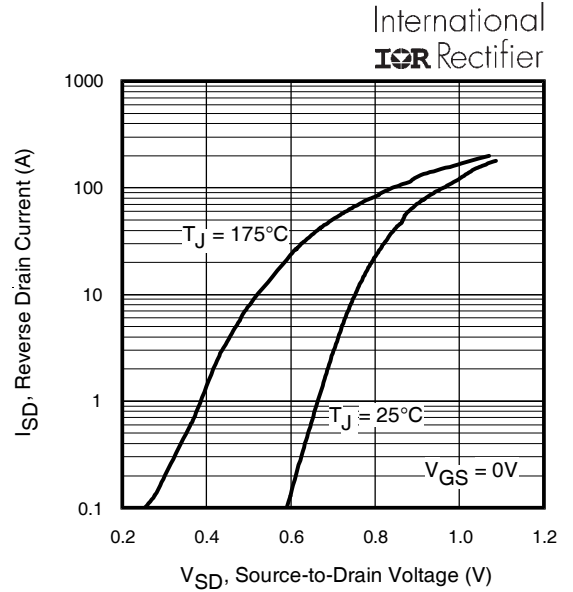


**Fig 6.** Typical  $E_{PULSE}$  vs. Drain Current

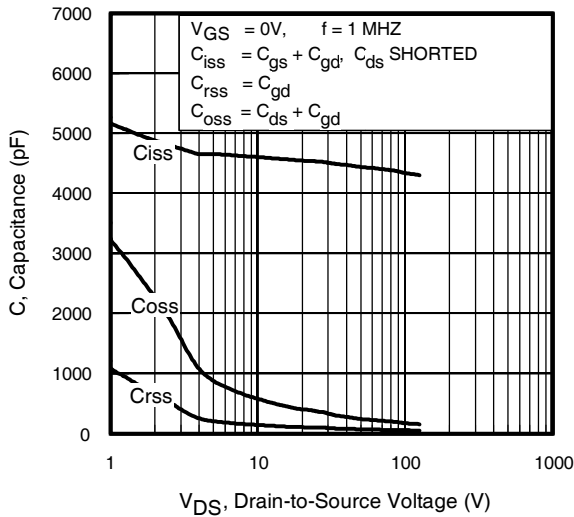
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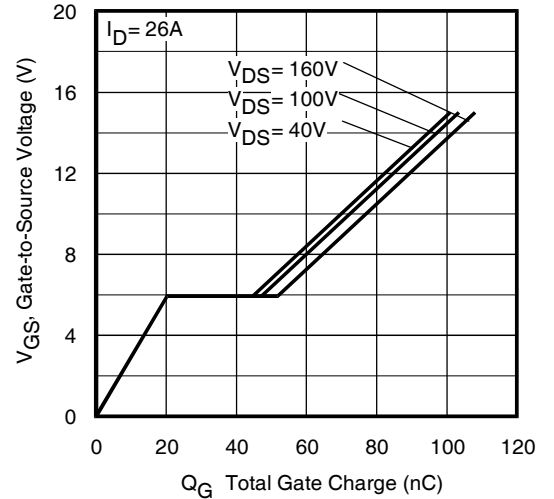
**Fig 7.** Typical  $E_{PULSE}$  vs. Temperature



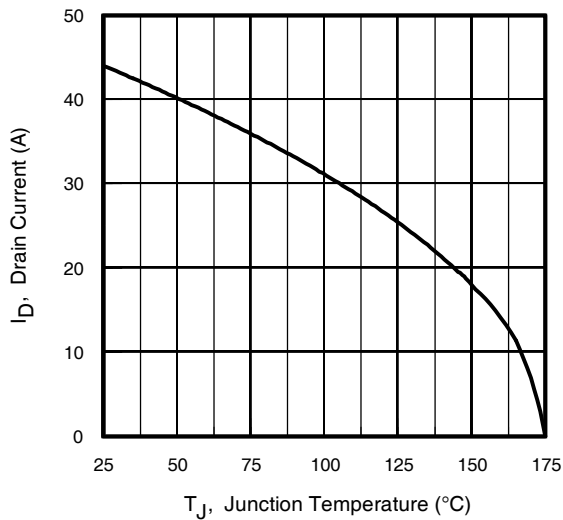
**Fig 8.** Typical Source-Drain Diode Forward Voltage



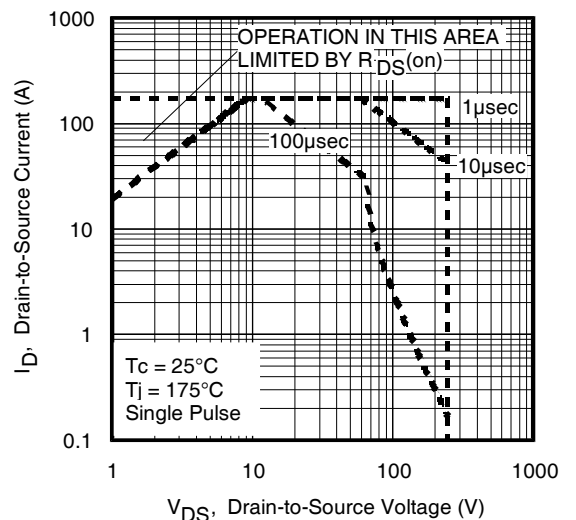
**Fig 9.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 10.** Typical Gate Charge vs. Gate-to-Source Voltage



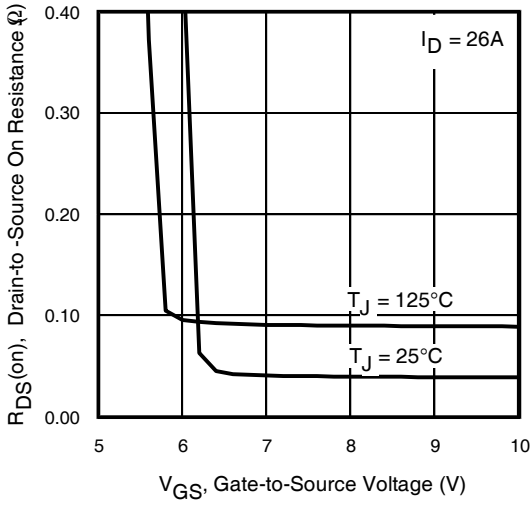
**Fig 11.** Maximum Drain Current vs. Case Temperature



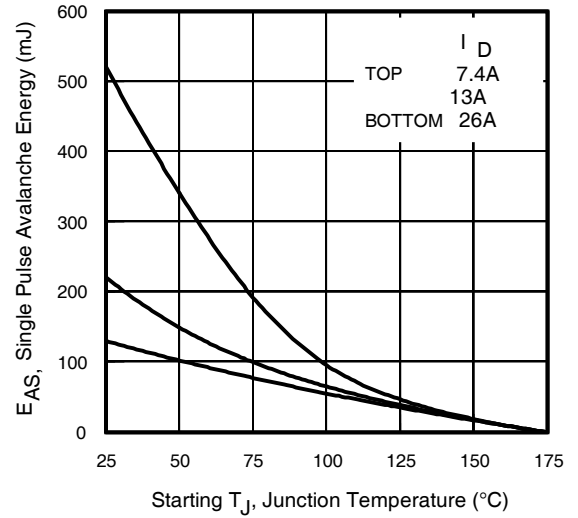
**Fig 12.** Maximum Safe Operating Area

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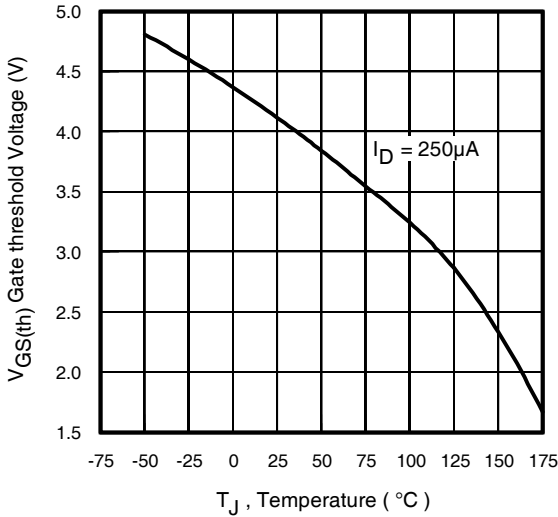
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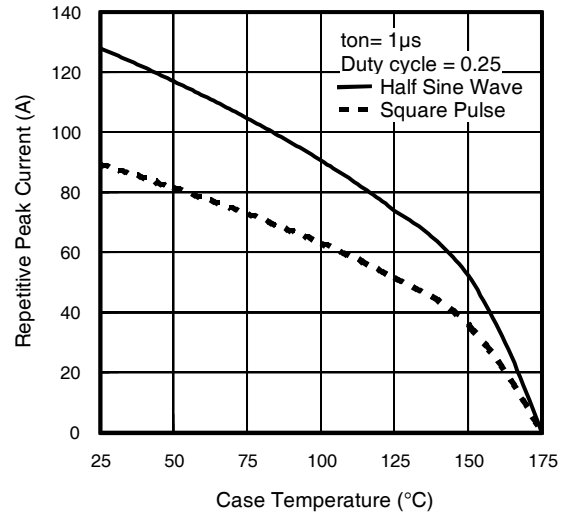
**Fig 13.** On-Resistance Vs. Gate Voltage



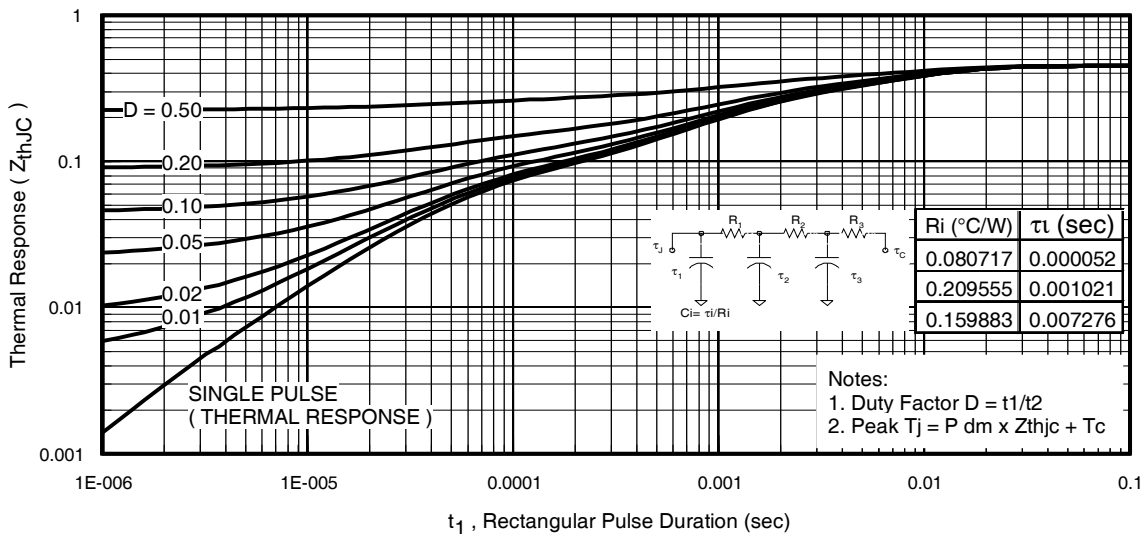
**Fig 14.** Maximum Avalanche Energy Vs. Temperature



**Fig 15.** Threshold Voltage vs. Temperature



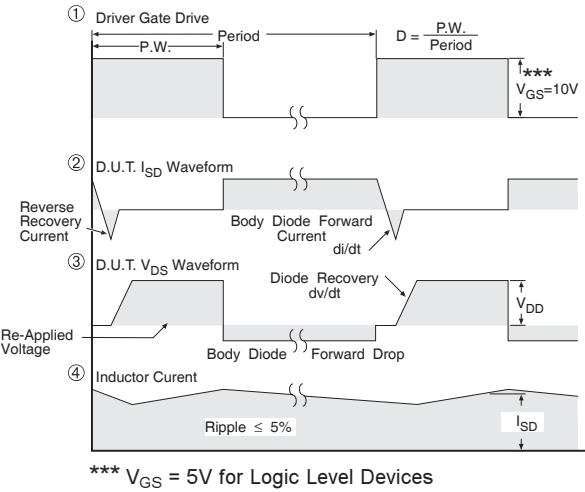
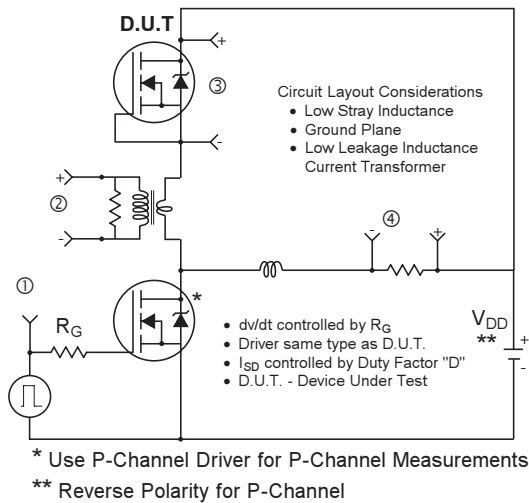
**Fig 16.** Typical Repetitive peak Current vs. Case temperature



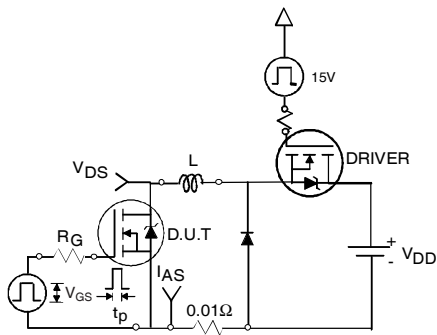
**Fig 17.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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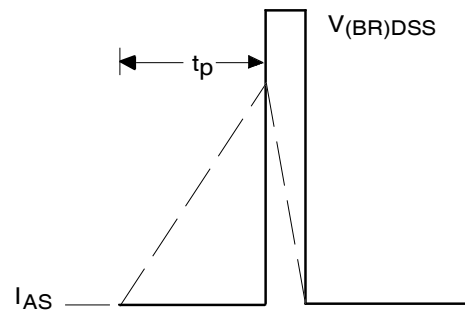
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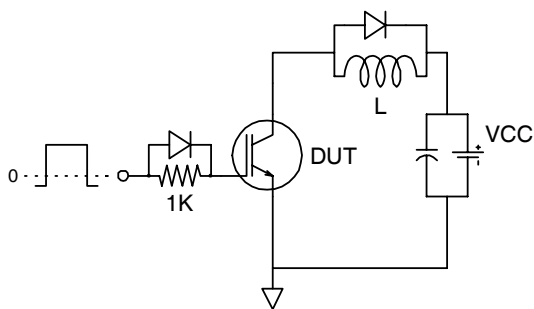
**Fig 18. Diode Reverse Recovery Test Circuit for HEXFET® Power MOSFETs**



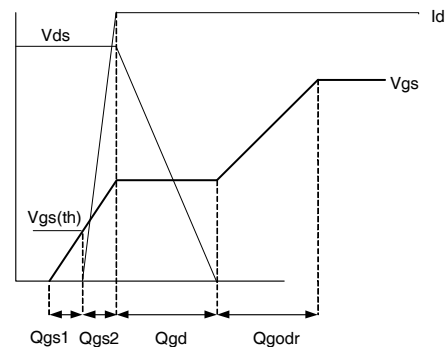
**Fig 19a. Unclamped Inductive Test Circuit**



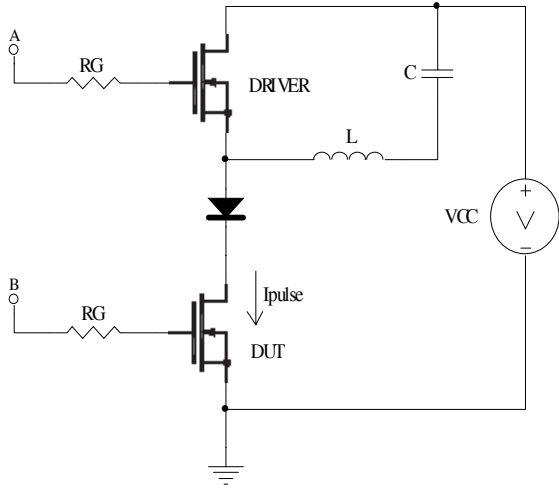
**Fig 19b. Unclamped Inductive Waveforms**



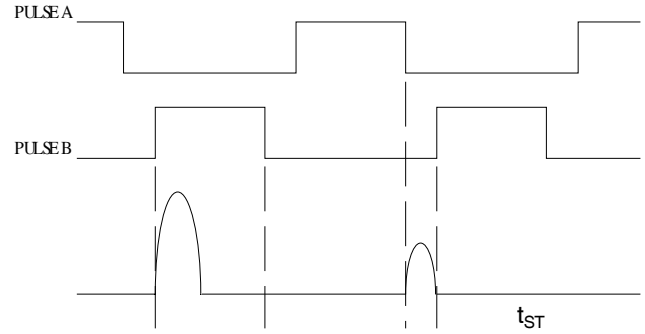
**Fig 20a. Gate Charge Test Circuit**



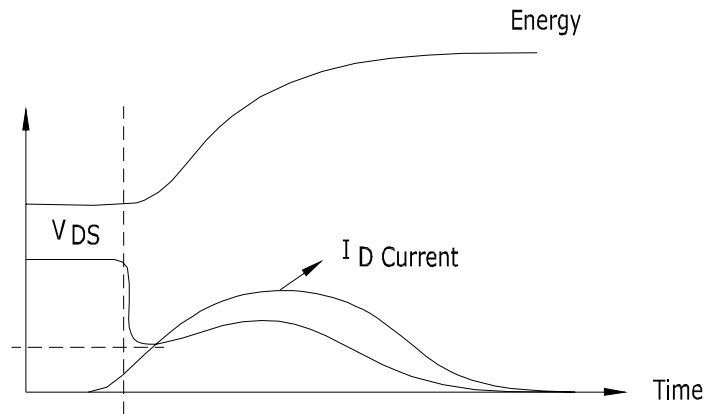
**Fig 20b. Gate Charge Waveform**



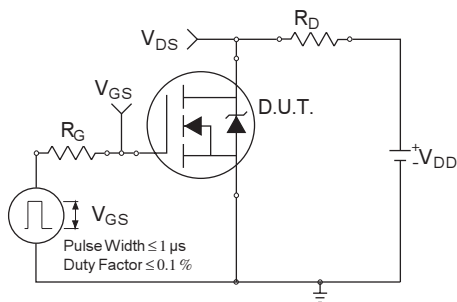
**Fig 21a.**  $t_{st}$  and  $E_{PULSE}$  Test Circuit



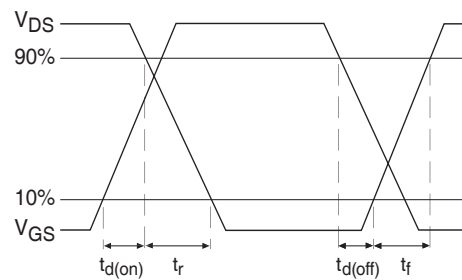
**Fig 21b.**  $t_{st}$  Test Waveforms



**Fig 21c.**  $E_{PULSE}$  Test Waveforms



**Fig 22a.** Switching Time Test Circuit



**Fig 22b.** Switching Time Waveforms

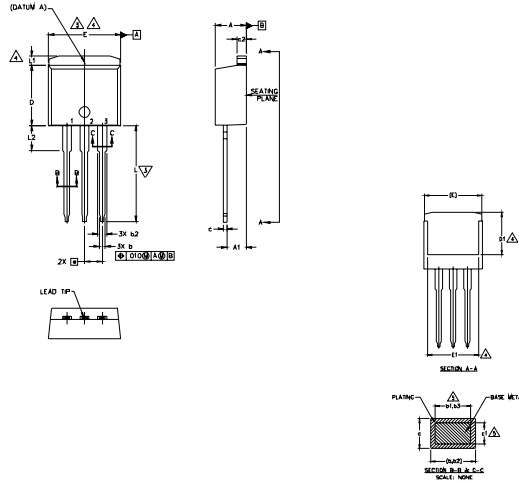


# IRFSL4229PbF



## TO-262 Package Outline

Dimensions are shown in millimeters (inches)



- NOTES:  
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994  
 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]  
 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 (.005) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.  
 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.  
 5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.  
 6. CONTROLLING DIMENSION: INCH.  
 7. OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.), D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 4.06        | 4.83  | .160     | .190 |       |
| A1     | 2.03        | 3.02  | .080     | .119 |       |
| b      | 0.51        | 0.99  | .020     | .039 |       |
| b1     | 0.51        | 0.89  | .020     | .035 | 5     |
| b2     | 1.14        | 1.78  | .045     | .070 |       |
| b3     | 1.14        | 1.73  | .045     | .068 | 5     |
| c      | 0.38        | 0.74  | .015     | .029 |       |
| c1     | 0.38        | 0.58  | .015     | .023 | 5     |
| c2     | 1.14        | 1.65  | .045     | .065 |       |
| D      | 8.38        | 9.65  | .330     | .380 | 3     |
| D1     | 6.86        | -     | .270     | -    | 4     |
| E      | 9.65        | 10.67 | .380     | .420 | 3,4   |
| E1     | 5.22        | -     | .205     | -    | 4     |
| e      | 2.54 BSC    | -     | .100 BSC | -    |       |
| L      | 13.46       | 14.10 | .530     | .550 |       |
| L1     | -           | 1.65  | -        | .065 |       |
| L2     | 3.56        | 3.71  | .140     | .146 |       |

**LEAD ASSIGNMENTS**

**HEFEET**

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

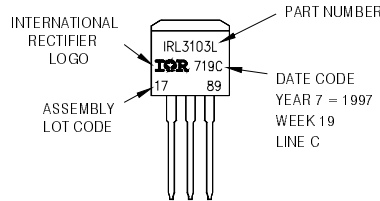
**IGBTs, CoPACK**

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

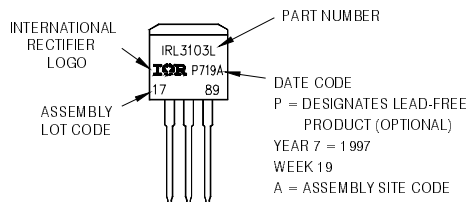
## TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE 'C'

Note: "P" in assembly line position indicates "Lead - Free"



OR



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.37\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 26\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④  $R_\theta$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .
- ⑤ Half sine wave with duty cycle = 0.25,  $t_{on} = 1\mu\text{sec}$ .

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.



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 TAC Fax: (310) 252-7903

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